

Notice of References Cited	Application/Control No. 10/003,258	Applicant(s)/Patent Under Reexamination OHMINAMI, NOBUYUKI	
	Examiner Wasseem H Hamdan	Art Unit 2854	Page 1 of 1

U.S. PATENT DOCUMENTS

★		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

★		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Phisics 3 Spring 1989; Lab 1; Capacitance Measurements.
	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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